No other camera even comes close

Superior light sensitivity Unmatched ease-of-use Unparalleled speed Outstanding resolution

Specifications

3:2

Sensor Active pixels Image area Pixel dimensions Aspect ratio CCD cooling Exposure control Exposure time Dynamic range Filter wheel Image readout rate Frame rate Computer interface

Large format interline transfer CCD 1280 H x 1024 V 8.6 mm x 6.9 mm, megapixel CCD 6.7 µm x 6.7 µm

Thermoelectric (Peltier), 40°C below ambient temperature Electronic shutter (no mechanical shutter) 100 microseconds to 20 minutes 10 bits (30-bit multipass color) 6 positions: IR cut, red, green, blue, clear (passes IR), black 16.9 million pixels/sec 10 fps, full field, full resolution IEEE-1394 (*Firewire™), 400 megabits/sec C-mount with standard C-mount backfocus (17.5 mm) Universal power input: 90 – 260 VAC, 50/60 Hz

Power requirements



*Firewire is a registered trademark of Apple Computer



As Easy As It Looks



Multi-Purpose and Low Vacuum Scanning Electron Microscope



All screens are clear and simple allowing easy system management and image optimization.

- Based on a Simple PC Interface.
- Intuitive Operation with a Mouse Alone.
- No Nonsense Transition Between Conventional and Low Vacuum Modes.
- Built-in DTP System Allows Quick and Easy Report Generation and Printing.
- A Special High Sensitivity Detector Allows High Image Quality In All Modes.

The new JSM-5600 and JSM-5600LV Scanning Electron Microscope was designed from the ground up as a PC SEM. This means that it can be controlled completely and efficiently from only the keyboard

JEOL USA, Inc., 11 Dearborn Road, Peabody, MA 01960 Tel: 978/535-5900 • Fax: 978/536-2205 Email: eod@jeol.com • WEB: http://www.jeol.com https://doi.org/10.1017/51431927600500208 Published online by Cambridge University Press and mouse. Keeping in mind the wide variety of preferences for controlling various aspects of an SEM we have also included an optional knobset for multitasking and fine control. You choose.

If you are currently in the market for a high end conventional or low vacuum SEM and need to combine state-of-the-art electronics with the versatility of computer control, we would like to invite you to come to our Applications Facility so that we can prove to you that it really is "As Easy As It Looks".

